Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/519,831	KOHINATA ET AL.	
Examiner	Art Unit	

Ellen Kim

2874

SEARCHED					
Class	Subclass	Date	Examiner		
385	11	8/13/2006	EK		
528	34	8/13/2006	EK		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
385	11	8/13/2006 EK		
528	34	8/13/2006	EK	

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY)
	DATE	EXMR
East	8/13/2006	EK
STN [done by EIC]	8/4/2006	EK